Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/792,043	YAN ET AL.	
Examiner	Art Unit	
Helen C. Kwok	2856	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
73	504.14	7/22/2005	нк		
73	504.04	7/22/2005	нк		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated Previous Search	7/22/2005	нк	
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